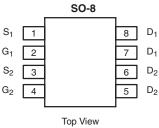




Dual N-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)		
30	0.016 at V _{GS} = 10 V	8			
	0.018 at V _{GS} = 4.5 V	8	19		
	0.024 at V _{GS} = 2.5 V	8			



Ordering Information: Si4922BDY-T1-E3 (Lead (Pb)-free)

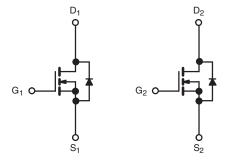
Si4922BDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

- Halogen-free According to IEC 61249-2-21 **Definition**
- TrenchFET® Power MOSFET
- 100 % R_q and UIS tested
- Compliant to RoHS Directive 2002/95/EC







N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T	$_{A}$ = 25 $^{\circ}$ C, unless other	erwise noted		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	± 12	v	
	T _C = 25 °C		8 ^e	
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C		8 ^e	
Continuous Diam Curient (1) = 130 °C)	T _A = 25 °C	I _D	8 ^{b, c, e}	
	T _A = 70 °C		6.6 ^{b, c}	
Pulsed Drain Current (10 µs Pulse Width)		I _{DM}	35	Α
Source-Drain Current Diode Current	T _C = 25 °C	I.	2.5	
Source-Dialit Current blode Current	T _A = 25 °C	ls –	1.7 ^{b, c}	
Pulsed Sorce-Drain Current		I _{SM}	35	
Single Pulse Avalanche Current		I _{AS}	15	
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	11.2	mJ
	T _C = 25 °C		3.1	
Maximum Power Dissipation	T _C = 70 °C	P _D	2	w
Maximum Fower Dissipation	T _A = 25 °C	' b	2 ^{b, c}	VV
	T _A = 70 °C		1.28 ^{b, c}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 50 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter			Limit			
		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	50	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{th IF}	30	40] 5/44	

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under Steady State conditions is 110 °C/W.
- e. Package Limited.

Si4922BDY

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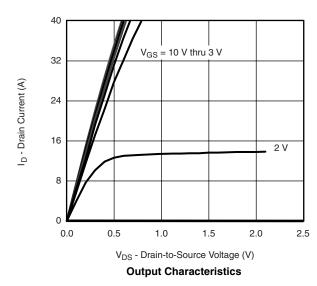
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit	
Static			ı				
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu A$		- 4.6			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6		1.8	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			100	nA	
Zero Gate Voltage Drain Current		V _{DS} = 30 V, V _{GS} = 0 V			1	μА	
	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10		
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α	
	` /	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		0.0135	0.016		
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 5 A		0.0145	0.018	Ω	
		$V_{GS} = 2.5 \text{ V}, I_D = 5 \text{ A}$		0.018	0.024	† <u></u>	
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 5 A		30		S	
Dynamic ^a	-		I			l.	
Input Capacitance	C _{iss}			2070			
Output Capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		255		pF	
Reverse Transfer Capacitance	C _{rss}	20 00		135			
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		41	62	nC	
Total Gate Charge	Qg	D3 / G3 / D		19	29		
Gate-Source Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		3.5			
Gate-Drain Charge	Q _{qd}	20 00 2		3.7			
Gate Resistance	R _a	f = 1 MHz		1.8	3	Ω	
Turn-On Delay Time	t _{d(on)}			7	14		
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 3 \Omega$		27	41		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_q = 1 \Omega$		31	47	-	
Fall Time	t _f	g		8	15		
Turn-On Delay Time	t _{d(on)}			13	25	ns	
Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_1 = 3 \Omega$		53	80	-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_q = 1 \Omega$		68	102		
Fall Time	t _f	<u> </u>		54	81		
Drain-Source Body Diode Characteristic	·						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.5	_	
Pulse Diode Forward Current ^a	I _{SM}	-			35	A	
Body Diode Voltage	V _{SD}	I _S = 1.7 A		0.77	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	<u> </u>		32	48	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 1.7 A, dI/dt = 100 A/μs, T _J = 25 °C		21	32	nC	
Reverse Recovery Fall Time	ta			13		ns	
Reverse Recovery Rise Time	t _b			19			

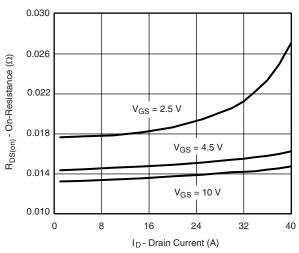
- a. Guaranteed by design, not subject to production testing.
- b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

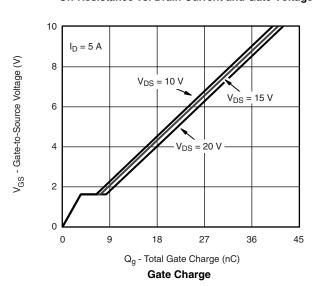


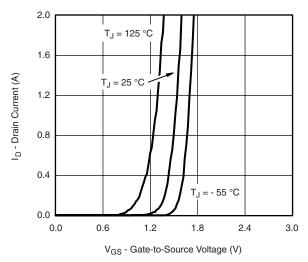
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



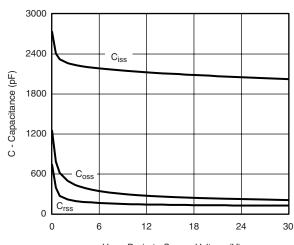


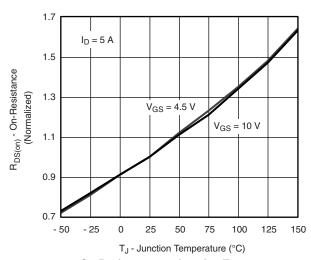
On-Resistance vs. Drain Current and Gate Voltage





Transfer Characteristics



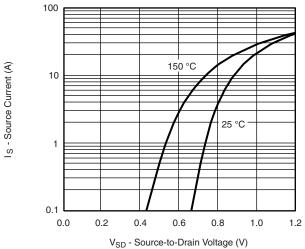


On-Resistance vs. Junction Temperature

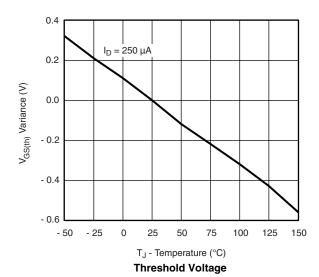
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

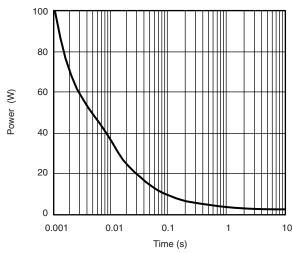


Source-Drain Diode Forward Voltage

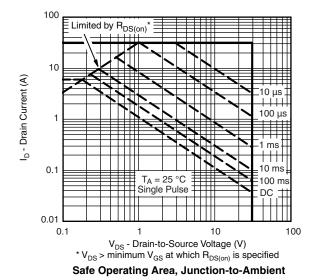


0.10 I_D = 5 A 0.08 R_{DS(on)} - On-Resistance (Ω) 0.06 0.04 125 °C 0.02 25 °C 0.00 2 0 1 5 6 V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

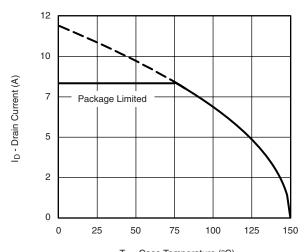


Single Pulse Power, Junction-to-Ambient



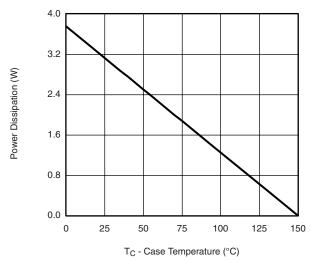


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

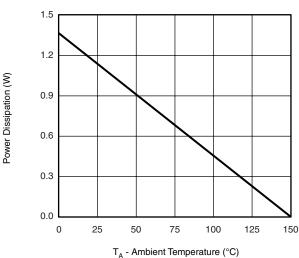


T_C - Case Temperature (°C)









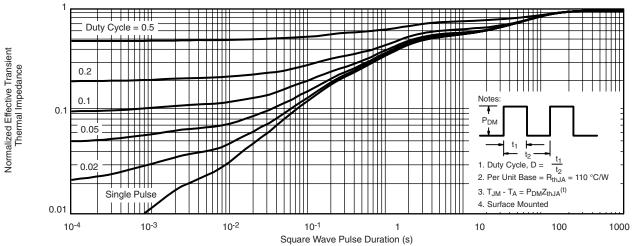
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

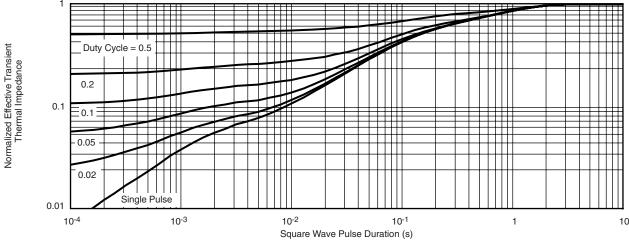
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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